imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





FGPF90N30 300V, 90A PDP IGBT

Features

- High Current Capability
- Low saturation voltage: V_{CE(sat) =}1.5V @ I_C = 60A
- High Input Impedance
- · Fast switch
- RoHS Complaint

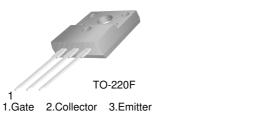
Application

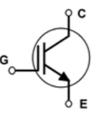
. PDP System



Description

Employing Unified IGBT Technology, Fairchild's PDP IGBTs provides low conduction and switching loss. FGPF90N30 offers the optimum solution for PDP applications where low-condution loss is essential.





Absolute Maximum Ratings

Symbol	Description		FGPF90N30	Units
V _{CES}	Collector-Emitter Voltage		300	V
V _{GES}	Gate-Emitter Voltage		± 30	V
I _{C pulse(1)}	Pulsed Collector Current	@ T _C = 25°C	220	A
P _D	Maximum Power Dissipation	@ T _C = 25°C	56.8	W
	Maximum Power Dissipation	@ T _C = 100°C	22.7	W
TJ	Operating Junction Temperature	•	-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction-to-Case		2.2	°C/W
R_{\thetaJA}	R _{0JA} Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Notes:

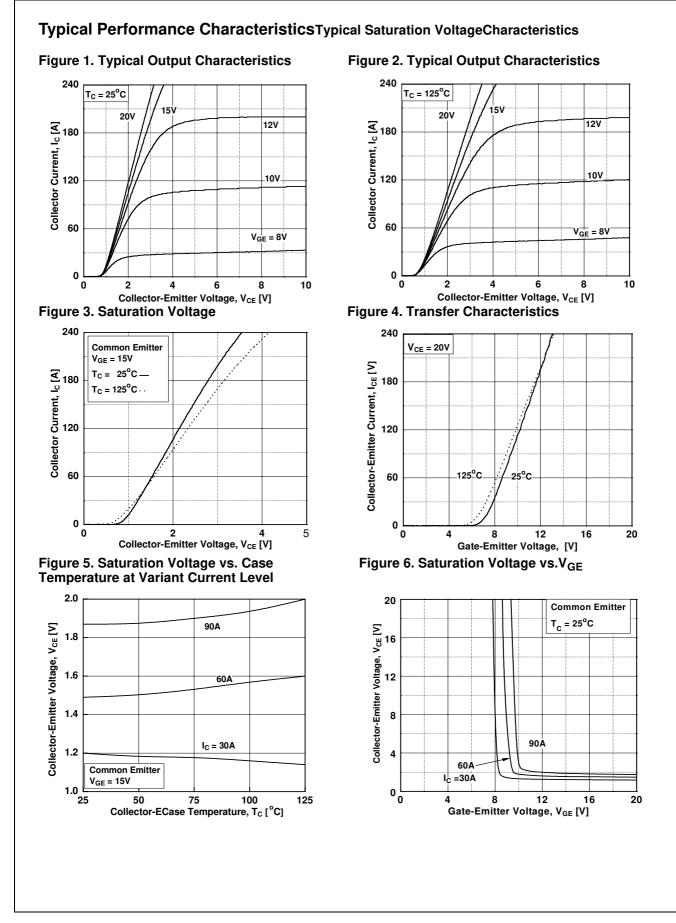
(1)Repetitive test , pluse width = 100usec , Duty = 0.1 $\,$

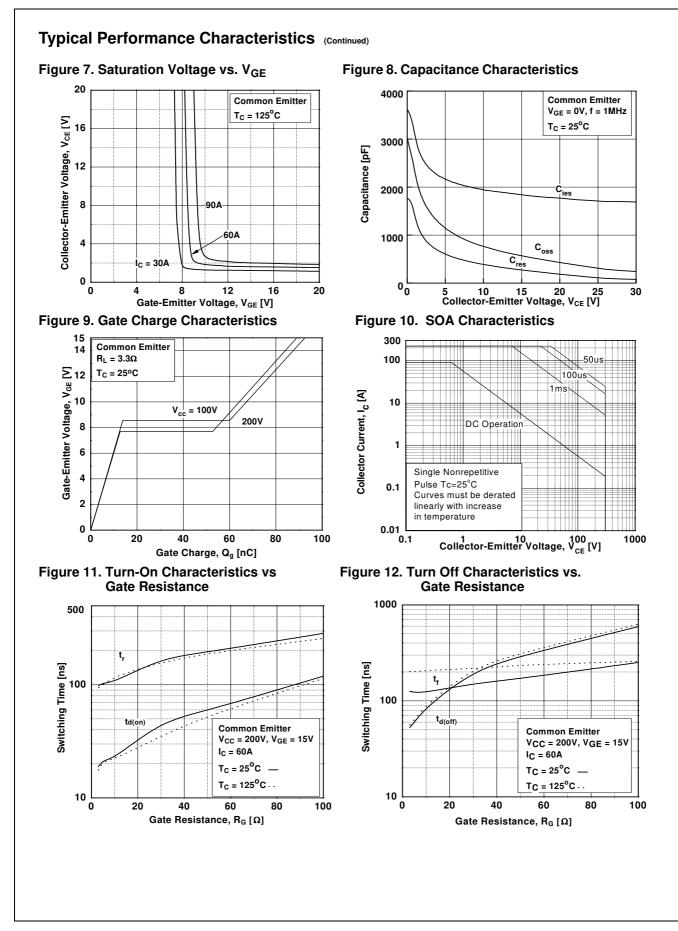
* Ic_pluse limited by max Tj

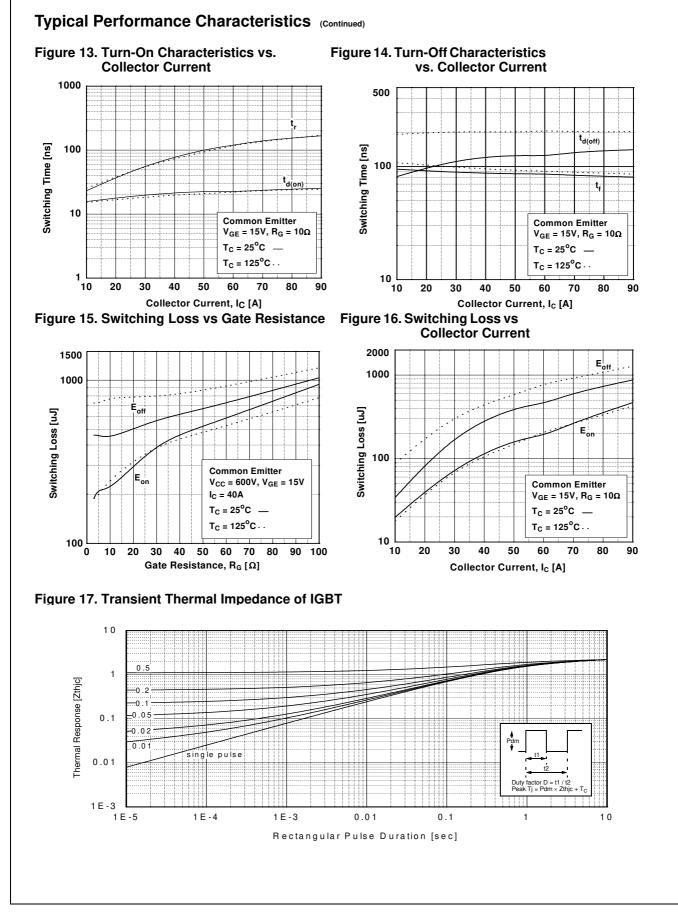
October 2006

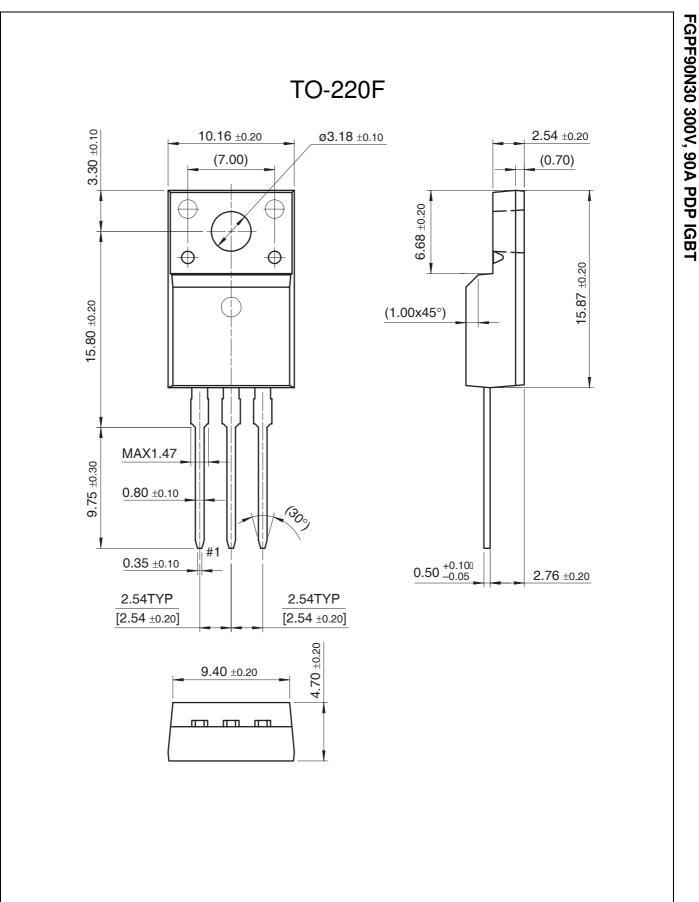
Т
Ω
D
Ť
Ö
Ο
Ζ
ω
0
ω
ö
Õ
<
<
, 9
V, 90,
, 9
V, 90,
V, 90A
V, 90A PI
V, 90A PI
V, 90A PDP IC
V, 90A PDP IGI
V, 90A PDP IC

		Device	Pac	Packaging ckage Type		Qty per	Tube		c Qty Box
		TO	O-220F Rail / Tube		50ea		-		
Electric	al Char	racteristics T _c	= 25°C unles	ss otherwise no	ited	·			
Symbol		Parameter		Te	st Conditions	Min.	Тур.	Max.	Units
	Acricalics					•			
Off Charac BV _{CES}	1	Emitter Breakdown Vo	Itage	$V_{OF} = 0V$	$L_{c} = 250 \mu A$	300			V
		or-Emitter Breakdown Voltage rature Coefficient of Breakdown		$V_{GE} = 0V, I_C = 250uA$		000			
$\frac{\Delta B_{VCES}}{\Delta T_J}$	Voltage	are coefficient of brea	kdown V _{GE} = 0V,		, I _C = 250uA		0.6		V/ºC
I _{CES}	Collector (Cut-Off Current		$V_{CE} = V_C$	_{ES} , V _{GE} = 0V			100	uA
I _{GES}	G-E Leaka	age Current		$V_{GE} = V_{GES}, V_{CE} = 0V$				± 250	nA
On Charac	teristics								
V _{GE(th)}	1	shold Voltage		I _C = 250uA, V _{CE} = V ₀		2.5	4.0	5.0	V
			I _C =30A, V _{GE} = 15V			1.25	1.55	V	
			I _C =60A, V _{GE} = 15V			1.5		V	
	Collector t	ollector to Emitter Saturation Voltage		$I_{C} = 90A, V_{GE} = 15V$ $T_{C} = 25^{\circ}C$			1.9		v
			$I_{C} = 90A, V_{GE} = 15V$ $T_{C} = 125^{\circ}C$			2.0		v	
Dynamic C	haracteris	tics							
C _{ies}	Input Cap						1690		pF
C _{oes}		Output Capacitance Reverse Transfer Capacitance		V _{CE} = 30V, V _{GE} = 0V f = 1MHz			240		pF
C _{res}	Reverse T						80		pF
Switching	Charactori	ation				1			
t _{d(on)}		Delay Time					22		ns
t _r	Rise Time	,		V _{CC} = 200 V, I _C = 60A			106		ns
t _{d(off)}		Delay Time			9, V _{GE} = 15V Load, T _o = 25⁰C		86		ns
t _f	Fall Time	•		Resistive Load, $T_{C} = 25^{\circ}C$			130	300	ns
t _{d(on)}	Turn-On E	Delay Time		1			22		ns
t _r	Rise Time			$V_{CC} = 200 \text{ V}, I_C = 60\text{A}$ - $R_G = 10\Omega, V_{GE} = 15\text{V}$ Resistive Load, $T_C = 125^{\circ}\text{C}$			119		ns
t _{d(off)}	Turn-Off D	Delay Time					91		ns
t _f	Fall Time			1			210		ns
Qg	Total Gate	e Charge		1			93		nC
Q _{ge}	Gate-Emit	tter Charge			0 V, I _C = 60A		45		nC
Q _{gc}	Gate-Colle	ector Charge		– V _{GE} = 15V			14		nC









TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™ ActiveArray™ Bottomless™ Build it Now™ CoolFET™ *CROSSVOLT*™ DOME™ EcoSPARK™ E²CMOS™ EnSigna™ FACT™ FAST® FASTr™ FPS™ FRFET™

FACT Quiet Series™ GlobalOptoisolator™ GTO™ HiSeC™ I²C™ i-Lo™ ImpliedDisconnect[™] IntelliMAX[™] **ISOPLANAR™** LittleFET™ MICROCOUPLER™ MicroFET™ MicroPak™ MICROWIRE™ MSX™ MSXPro™ Across the board. Around the world.™

OCX™ OCXPro™ OPTOLOGIC[®] **OPTOPLANAR™** PACMAN™ POP™ Power247[™] PowerEdge™ PowerSaver™ PowerTrench[®] QFET[®] QS™ QT Optoelectronics™ Quiet Series[™] RapidConfigure™ RapidConnect™ µSerDes™ ScalarPump™

SILENT SWITCHER[®] SMART START™ SPM™ Stealth™ SuperFET™ SuperSOT™-3 SuperSOT[™]-6 SuperSOT™-8 SyncFET™ TCM™ TinyBoost™ TinyBuck™ TinyPWM™ TinyPower™ TinyLogic[®] TINYOPTO™ TruTranslation™ UHC™

UniFET™ UltraFET[®] VCX™ Wire™

DISCLAIMER FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARDANTY THEREIN. WHICH COVERS THESE PRODUCTS.

The Power Franchise[®]

Programmable Active Droop™

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition		
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.		
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.		
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.		
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.		

Rev. I20